

Test Report

(EN 50155 & EN 50121-3-2)

Report No.: CEBDBO-WTW-P23050006-1

Test Model: ECX-3200

- **Received Date:** 2023/5/2
 - Test Date: 2023/5/4 ~ 2023/5/11

Issued Date: 2023/5/23

Applicant: Vecow Co., Ltd.

- Address: 3F., No.10, Jiankang Rd., Zhonghe Dist., New Taipei City 23586, Taiwan
- **Issued By:** Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch Lin Kou Laboratories
- Lab Address: No. 47-2, 14th Ling, Chia Pau Vil., Lin Kou Dist., New Taipei City, Taiwan



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Release Control Record

Issue No.	Description	Date Issued
CEBDBO-WTW-P23050006-1	Original release.	2023/5/23



1 Certificate of Conformity

Product:	Expandable Fanless Embedded Workstation
Brand:	Vecow
Test Model:	ECX-3200
Series Model:	ECX-3XXXXXXXXXXXXXXXXXXXXXXXXXXXXXXXXXXX
Sample Status:	Engineering sample
Applicant:	Vecow Co., Ltd.
Test Date:	2023/5/4 ~ 2023/5/11
Standards:	EN 50155:2017, Clause 13.4.8
	EN 61000-3-2:2014, Class A
	EN IEC 61000-3-2:2019 +A1:2021, Class A
	EN 61000-3-3:2013 +A2:2021, Class A
	EN 50121-1:2017
	EN 50121-3-2:2016
	EN 61000-4-2:2009
	EN 61000-4-3:2006 +A1:2008 +A2:2010
	EN IEC 61000-4-3:2020
	EN 61000-4-4:2012
	EN 61000-4-5:2014 +A1:2017
	EN 61000-4-6:2014 +AC:2015

The above equipment has been tested by **Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch**, and found compliance with the requirement of the above standards. The test record, data evaluation & Equipment Under Test (EUT) configurations represented herein are true and accurate accounts of the measurements of the sample's EMC characteristics under the conditions specified in this report.

Prepared by :

ee Un

Albee Chu / Specialist

Approved by :

Jim Haiang

Date:

Date:

2023/5/23

2023/5/23

Jim Hsiang / Associate Technical Manager



2 Summary of Test Results

EN 50121-3-2:2016, Emission requirements,				
EN 50155:2017, Clause 13.4.8				
Port Test Item / specifications Result/Remarks				
Auxiliary a.c. or d.c. power ports - Auxiliary supply sinusoidal a.c. or d.c.	Conducted disturbance 150 kHz- 500 kHz: 99 dBµV quasi-peak 500 kHz- 30 MHz: 93 dBµV quasi-peak	Minimum passing margin is -47.84 dB at 1.60406 MHz	Pass	
Auxiliary a.c. or d.c. power ports – AC power outlet port for public use	Conducted disturbance 50 Hz- 2 kHz: THD <8% (THD: total harmonic distortion)	Test not applicable because the port does not exist.	N/A	
Battery referenced ports - Battery power supply	Conducted disturbance 150 kHz- 500 kHz: 99 dBµV quasi-peak 500 kHz- 30 MHz: 93 dBµV quasi-peak	Test not applicable because the port does not exist.	N/A	
Enclosure	Radiated disturbance 30 MHz- 230 MHz: 40 dBµV/m quasi-peak 230 MHz -1 GHz: 47 dBµV/m quasi-peak	Minimum passing margin is -0.81 dB at 662.49 MHz	Pass	
Enclosure	Radiated disturbance 1 GHz- 3 GHz: 76 dBµV/m peak 56 dBµV/m average 3 GHz - 6 GHz: 80 dBµV/m peak 60 dBµV/m average	Minimum passing margin is -5.63 dB at 1539.98 MHz	Pass	

Emission requirements			
Standard Test Item / specifications Result/Remarks		Verdict	
EN 61000-3-2:2014 EN IEC 61000-3-2:2019+A1:2021 Harmonic current emissions		Meets Class A Limit	Pass
EN 61000-3-3:2013+A2:2021	Voltage fluctuations and flicker	$ \begin{array}{ll} P_{st} \leqq 1.0 & d_{max} \leqq 4\% \\ P_{lt} \leqq 0.65 & d_c \leqq 3.3\% \\ T_{max} \leqq 500 ms \end{array} $	Pass



	EN 50121-3-2:2016, Immunity requirements,				
Tabla	EN 50155:2017, Clause 13.4.8				
Table Clause	Basic standard	Port	Test Item / specifications	Result/Remarks	Verdict
3.1	EN 61000-4-6:2014 +AC:2015	Battery referenced ports (except at the output of energy sources), Auxiliary a.c. power input ports (rated voltage ≤ 400 Vrms)	Radio-frequency common mode (CS) 80% AM (1kHz) 0.15-80 MHz, 10V Performance Criterion A	Performance Criterion A	Pass
3.2	EN 61000-4-4:2012	Battery referenced ports (except at the output of energy sources), Auxiliary a.c. power input ports (rated voltage ≤ 400 Vrms)	Fast Transients (EFT) 5/50 (t _r /t _w) ns, 5kHz ±2kV Performance Criterion A	Performance Criterion A	Pass
3.3	EN 61000-4-5:2014 +A1:2017	Battery referenced ports (except at the output of energy sources), Auxiliary a.c. power input ports (rated voltage ≤ 400 Vrms)	Surges 1.2/50 (8/20) $(T_f/T_d) \mu s$ Line to ground: ±2kV 42 Ω , 0.5 μF Line to line: ±1kV 42 Ω , 0.5 μF Performance Criterion B	Performance Criterion A	Pass
4.1	EN 61000-4-6:2014 +AC:2015	Signal & communication, process measurement & control ports	Radio-frequency common mode (CS) 80% AM (1kHz) 0.15-80 MHz, 10V Performance Criterion A	Performance Criterion A	Pass
4.2	EN 61000-4-4:2012	Signal & communication, process measurement & control ports	Fast Transients (EFT) 5/50 (t _r /t _w) ns, 5kHz ±2kV, Capacitive clamp Performance Criterion A	Performance Criterion A	Pass
5.1	EN 61000-4-3:2006 +A1:2008 +A2:2010/ EN IEC 61000-4-3:2020	Enclosure ports	Radio-frequency electromagnetic field amplitude modulated (RS) ¹ , 80% AM (1kHz) 80-800 MHz, 20V/m Performance Criterion A	Performance Criterion A	Pass
5.2	EN 61000-4-3:2006 +A1:2008 +A2:2010/ EN IEC 61000-4-3:2020	Enclosure ports	Radio-frequency electromagnetic field from digital mobile telephones (RS) ² , 80% AM (1kHz) 800-1000 MHz, 20V/m 1400-2000 MHz, 20V/m 2000-2700 MHz, 5V/m 5100-6000 MHz, 3V/m Performance Criterion A	Performance Criterion A	Pass



EN 50121-3-2:2016, Immunity requirements, EN 50155:2017, Clause 13.4.8					
Table Clause	Basic standard Port Lest Item / specifications Result/Remarks IVerdu				
5.3	EN 61000-4-2:2009	Enclosure ports	Electrostatic Discharges (ESD) ±6kV Contact discharge ±8kV Air discharge Performance Criterion B	Performance Criterion B	Pass
Note 1: This limit applies to equipment mounted in the passenger compartments, drivers cab or external to the rolling stock (roof, underframe). For equipment mounted in all other areas a severity level of 10 V/m may be used.					

Note 2: For large apparatus (e.g. traction drives, auxiliary converters) it is often not practical to perform the immunity test to radiated electromagnetic fields on the complete unit. In such cases the manufacturer should test susceptible sub-systems (e.g. control electronics). The test report should justify the selection or not of sub-systems and any assumptions made (e.g. reduction of field due to case shielding).

Note:

1. There is no deviation to the applied test methods and requirements covered by the scope of this report.

The above EN basic standards are applied with latest version if customer has no special requirement.
 Determining compliance based on the results of the compliance measurement, not taking into account measurement instrumentation uncertainty.

4. N/A: Not Applicable



2.1 Performance Criteria

General Performance Criteria

The general performance criteria apply for those ports for which no specific performance criteria are defined (e.g. auxiliary ports) in the report.

Performance criterion A: The apparatus shall continue to operate as intended during and after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, either of these may be derived from the product description and documentation, and from what the user may reasonably expect from the apparatus if used as intended..

Performance criterion B: The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed. No change of actual operating state or stored data is allowed. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, either of these may be derived from the product description and documentation, and from what the user may reasonably expect from the apparatus if used as intended.

Performance criterion C: Temporary loss of function is allowed, provided the function is self-recoverable or can be restored by the operation of the controls.

2.2 Measurement Uncertainty

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2:

Measurement	Expanded Uncertainty (k=2) (±)	Maximum allowable uncertainty (±)
Conducted disturbance at mains port using AMN, 150kHz ~ 30MHz	3.00 dB	3.4 dB (U _{cispr})
Radiated disturbance, 30MHz ~ 1GHz	3m : 5.72 dB 10m : 4.38 dB	6.3 dB (<i>U</i> _{cispr})
Radiated disturbance, 1GHz ~ 6GHz	4.42 dB	5.2 dB (<i>U</i> _{cispr})

The other instruments specified are routine verified to remain within the calibrated levels, no measurement uncertainty is required to be calculated.

2.3 Modification Record

There were no modifications required for compliance.



3 General Information

3.1 Description of EUT

Product	Expandable Fanless Embedded Workstation
Brand	Vecow
Test Model	ECX-3200
Series Model	ECX-3XXXXXXXXXXXXXXXXXXXXXXXXXXXXXXXXXXX
Sample Status	Engineering sample
Operating Software	WIN10
Power Supply Rating	DC from Adapter
Accessory Device	Adapter
Data Cable Supplied	N/A

Note:

The EUT uses following accessory.

AC Adapter				
Brand	Model	Specification		
		AC Input : 100~240V, 2.34A 50-60Hz		
LITEON	PA-1181-28E	DC Output : 24V, 7.5A 180W		
		DC Output Cable: 1.5m, with 2 cores.		

3.2 Features of EUT

1. The tests reported herein were performed according to the method specified by Vecow Co., Ltd., for detailed feature description, please refer to the manufacturer's specifications or user's manual.

2. The EUT configured with the following key components:

Commence	
Component	Specification
CPU	Intel [®] Core [™] 12 th Gen Processor
RAM	SMART DDR5 4800 8GB non-ECC SODIMM x2
SSD	Innodisk 2.5" SATA SSD 3ME4 128GB



3.3 Operating Modes of EUT and Determination of Worst Case Operating Mode

1. The EUT has been pre-tested under following test modes.

	Test Condition					
Mode	Radiated Emissions up to 1 GHz					
1	Full system,DVI+HDMI:1920*1080,60Hz,Display:3480*2160,60Hz,LAN 1:1Gbps link, LAN 2:1Gbps link, LAN 3~LAN 6 with POE CCD					
Note: There are both AC 230V/50Hz and AC 120V/60Hz to be pre-tested then AC 120V/60Hz has the highest emission value.						

2. Test modes are presented in the report as below.

	Test Condition						
Mode	Conducted Emissions from Power Ports						
A	Full system,DVI+HDMI:1920*1080,60Hz,Display:3480*2160,60Hz,LAN 1:1Gbps link, LAN 2:1Gbps link, LAN 3~LAN 6 with POE CCD + Input Power(230 Vac, 50 Hz)						
Mode	Radiated Emissions up to 1 GHz						
A	ull system,DVI+HDMI:1920*1080,60Hz,Display:3480*2160,60Hz,LAN 1:1Gbps link, AN 2:1Gbps link, LAN 3~LAN 6 with POE CCD + Input Power(120 Vac, 60 Hz)						
Mode	Radiated Emissions above 1 GHz						
A	Full system,DVI+HDMI:1920*1080,60Hz,Display:3480*2160,60Hz,LAN 1:1Gbps link, LAN 2:1Gbps link, LAN 3~LAN 6 with POE CCD + Input Power(120 Vac, 60 Hz)						
Mode	Harmonic Current Measurement						
А	Full system,DVI+HDMI:1920*1080,60Hz,Display:3480*2160,60Hz,LAN 1:1Gbps link,LAN 2:1Gbps link,LAN 3~LAN 6 with POE CCD + Input Power(230 Vac, 50 Hz)						
Mode	Voltage Fluctuations and Flicker Measurement						
А	Full system,DVI+HDMI:1920*1080,60Hz,Display:3480*2160,60Hz,LAN 1:1Gbps link,LAN 2:1Gbps link,LAN 3~LAN 6 with POE CCD + Input Power(230 Vac, 50 Hz)						
Mode	Electrostatic Discharges (ESD)						
А	Full system,DVI+HDMI:1920*1080,60Hz,Display:3480*2160,60Hz,LAN 1:1Gbps link,LAN 2:1Gbps link,LAN 3~LAN 6 with POE CCD + Input Power(230 Vac, 50 Hz)						
Mode	Radio Frequency Electromagnetic Field (RS)						
А	Full system,DVI+HDMI:1920*1080,60Hz,Display:3480*2160,60Hz,LAN 1:1Gbps link,LAN 2:1Gbps link,LAN 3~LAN 6 with POE CCD + Input Power(230 Vac, 50 Hz)						
Mode	Fast Transients Common Mode (EFT)						
A	Full system,DVI+HDMI:1920*1080,60Hz,Display:3480*2160,60Hz,LAN 1:1Gbps link,LAN 2:1Gbps link,LAN 3~LAN 6 with POE CCD + Input Power(230 Vac, 50 Hz)						
Mode	Surges						
A	Full system,DVI+HDMI:1920*1080,60Hz,Display:3480*2160,60Hz,LAN 1:1Gbps link,LAN 2:1Gbps link,LAN 3~LAN 6 with POE CCD + Input Power(230 Vac, 50 Hz)						
Mode	Radio Frequency Common Mode (CS)						
А	Full system,DVI+HDMI:1920*1080,60Hz,Display:3480*2160,60Hz,LAN 1:1Gbps link,LAN 2:1Gbps link,LAN 3~LAN 6 with POE CCD + Input Power(230 Vac, 50 Hz)						

3.4 Test Program Used and Operation Descriptions

Emission tests (Harmonics & Flicker excluded):

- a. Turned on the power of all equipment.
- b. EUT ran a test program (BurnIntest) to enable all functions.
- c. EUT read and wrote messages to/ from internal storage drives, and external storage drives.
- d. EUT sent "H" messages to monitor. Then the displayed messages on their screens simultaneously.
- e. EUT sent and received messages to/ from Laptop (kept in a remote area) via STP cable.
- f. EUT received message from POE camera via STP cable.
- g. EUT sent "1kHz audio" signal to earphone.
- h. Steps c-g were repeated.

Harmonics & Flicker & Immunity tests:

- a. Turned on the power of all equipment.
- b. EUT ran a test program (BurnIntest) to enable all functions.
- c. EUT read and wrote messages to/ from internal storage drives, and external storage drives.
- d. EUT sent "color bars with moving element" messages to monitor. Then the displayed messages on their screens simultaneously.
- e. EUT sent and received messages to/ from Laptop (kept in a remote area) via STP cable.
- f. EUT received message from POE camera via STP cable.
- g. EUT sent "1kHz audio" signal to Headset.
- h. Steps c-g were repeated.
- i.

3.5 Primary Clock Frequencies of Internal Source

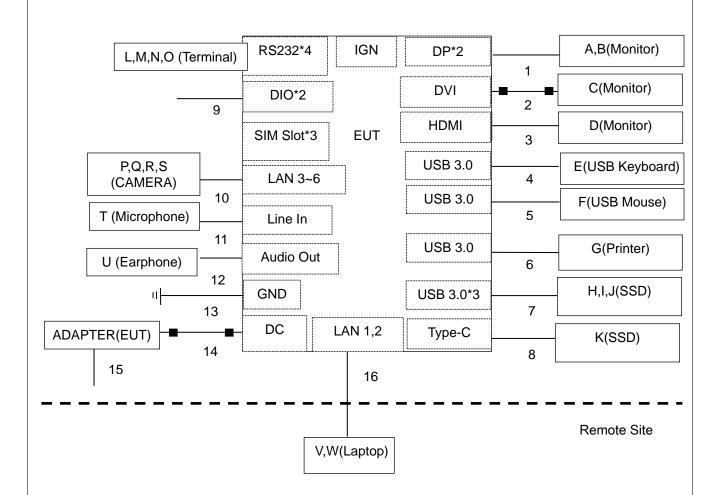
The highest frequency generated or used within the EUT or on which the EUT operates or tunes is 1.9GHz, provided by Vecow Co., Ltd., for detailed internal source, please refer to the manufacturer's specifications.



4 Configuration and Connections with EUT

4.1 Connection Diagram of EUT and Peripheral Devices

Emission tests (Harmonics & Flicker excluded):





Harmonics & Flicker & Immunity tests: IGN A,B(Monitor) DP*2 L,M,N,O (Terminal) RS232*4 1 C(Monitor) DVI DIO*2 2 9 HDMI D(Monitor) EU SIM Slot*3 3 **USB 3.0** E(USB Keyboard) P,Q,R,S LAN 3~6 4 (CAMERA) 10 USB 3.0 F(USB Mouse) 5 T (Headset) Line In 11 Audio Out G,H,I,J(External GND USB 3.0*4 Hard Disk) 7 12 DC LAN 1,2 ADAPTER(EUT) Type-C K(External Hard 13 8 Disk) 14 6 **Remote Site** U,V(Laptop)



Emission tests (Harmonics & Flicker excluded):							
ID	Product	Brand	Model No.	Serial No.	FCC ID	Remarks	
А	Monitor	ASUS	PA279CV	M7LMTF235958	DoC	Provided by Lab	
В	Monitor	ASUS	PA279CV	M7LMTF236012	DoC	Provided by Lab	
С	Monitor	DELL	U2410	CN082WXD728720C C0KCL	DoC	Provided by Lab	
D	Monitor	DELL	U2410	CN082WXD728720C C10NL	DoC	Provided by Lab	
Е	USB Keyboard	Dell	KB216t	CN-0W33XP-LO300- 7CL-191E	N/A	Provided by Lab	
F	USB Mouse	DELL	MOCZUL	CN-049TWY-PRC00- 77B-007R	N/A	Provided by Lab	
G	Printer	HP	HP Officejet Pro 251dW	N/A	B94SDGOB1191	Provided by Lab	
Н	SSD	Crucial	CT500X8SSD9	1941E323D093	N/A	Provided by Lab	
Ι	SSD	Crucial	CT500X8SSD9	1941E323D095	N/A	Provided by Lab	
J	SSD	Crucial	CT500X8SSD9	1941E3201117	N/A	Provided by Lab	
К	SSD	Crucial	CT500X8SSD9	1941E320114D	N/A	Provided by Lab	
L	Terminal	N/A	N/A	N/A	N/A	Supplied by applicant	
М	Terminal	N/A	N/A	N/A	N/A	Supplied by applicant	
Ν	Terminal	N/A	N/A	N/A	N/A	Supplied by applicant	
0	Terminal	N/A	N/A	N/A	N/A	Supplied by applicant	
Р	CAMARA	3MP	A301RZ-0309P	T42211285	N/A	Supplied by applicant	
Q	CAMARA	3MP	A301RZ-0309P	T42211278	N/A	Supplied by applicant	
R	CAMARA	3MP	A301RZ-0309P	T42211283	N/A	Supplied by applicant	
S	CAMARA	3MP	A301RZ-0309P	T42211277	N/A	Supplied by applicant	
Т	Microphone	E-books	E-EPB099	N/A	N/A	Provided by Lab	
U	Earphonne	PHILIPS	SBC HL145	N/A	N/A	Provided by Lab	
V	Laptop	LENOVO	T480	PF1EK03U	N/A	Provided by Lab	
W	Laptop	LENOVO	T480	PF1EZSAW	N/A	Provided by Lab	

4.2 Configuration of Peripheral Devices and Cable Connections

Report No.: CEBDBO-WTW-P23050006-1 Reference No.: BDBO-WTW-P23050006



						<u>. </u>
ID		0.5	Length	Shielding	Cores	Demerica
U	Cable Descriptions	Qty.	(m)	(Yes/No)	(Qty.)	Remarks
1	DP cable	2	1.8	Yes	0	Provided by Lab
2	DVI cable	1	1.8	Yes	2	Provided by Lab
						Provided by Lab,
3	HDMI cable	1	2	Yes	0	HDMI 2.0
						(Brand: Amber,
						Model: HDMI-AA120)
4	USB cable	1	1.8	Yes	0	Provided by Lab
5	USB cable	1	1.8	Yes	0	Provided by Lab
6	USB cable	1	1.8	Yes	0	Provided by Lab
7	USB Type A to C cable	3	1	Yes	0	Provided by Lab
8	Type C to C cable	1	1	Yes	0	Provided by Lab
9	Data cable	5	0.3	No	0	Supplied by applicant
10	RJ45 (Cat. 5e) cable	4	1.5	Yes	0	Provided by Lab
11	Audio (3.5") cable	1	2	No	0	Provided by Lab
12	Audio (3.5") cable	1	1.2	No	0	Provided by Lab
13	GND (PE) cable	1	1.8	No	0	Provided by Lab
14	DC power cable	1	1.5	No	2	Accessory of EUT
15	AC power(3pin) cable	1	1.8	No	0	Provided by Lab
16	RJ45 (Cat. 5e) cable	2	10	Yes	0	Provided by Lab



Tiain	ionics, Flicker, In		-515.			
ID	Product	Brand	Model No.	Serial No.	FCC ID	Remarks
А	Monitor	DELL	P2415Qb	CN-OGTTPW-74261-66 2-OAGL	N/A	Provided by Lab
В	Monitor	ASUS	MG28UQ	H8LMTF147971	N/A	Provided by Lab
С	Monitor	DELL	U2413f	CN-06VNX5-72872-42B -A4EL	DoC	Provided by Lab
D	Monitor	ASUS	MG28UQ	HCLMTF053703	N/A	Provided by Lab
Е	USB Keyboard	HP	SK-2085	N/A	N/A	Provided by Lab
F	USB Mouse	DELL	MS116p	CN-0145WW-PRC00-01 D-054P	DoC	Provided by Lab
G	External Hard Disk	WD	WDBATL5000ABK	2121FZ400129	N/A	Provided by Lab
Н	External Hard Disk	WD	WDBATL5000ABK	2121FZ400551	N/A	Provided by Lab
Ι	External Hard Disk	WD	WDBATL5000ABK	2121FZ400465	N/A	Provided by Lab
J	External Hard Disk	WD	WDBATL5000ABK	2121FZ400062	N/A	Provided by Lab
К	External Hard Disk	WD	WDBATL5000ABK	2121FZ400674	N/A	Provided by Lab
L	Terminal	N/A	N/A	N/A	N/A	Supplied by applicant
Μ	Terminal	N/A	N/A	N/A	N/A	Supplied by applicant
Ν	Terminal	N/A	N/A	N/A	N/A	Supplied by applicant
0	Terminal	N/A	N/A	N/A	N/A	Supplied by applicant
Ρ	CAMARA	3MP	A301RZ-0309P	T42211285	N/A	Supplied by applicant
Q	CAMARA	3MP	A301RZ-0309P	T42211278	N/A	Supplied by applicant
R	CAMARA	3MP	A301RZ-0309P	T42211283	N/A	Supplied by applicant
S	CAMARA	3MP	A301RZ-0309P	T42211277	N/A	Supplied by applicant
Т	Headset	E-books	E-EPB099	N/A	N/A	Provided by Lab
U	Laptop	Dell	E5420	FHNT4S1	N/A	Provided by Lab
V	Laptop	Dell	E5430	DJ9CVY1	N/A	Provided by Lab

Harmonics, Flicker, Immunity tests:



5	Oskla Deseriations	Oth	Length	Shielding	Cores	Demerius
ID	Cable Descriptions	Qty.	(m)	(Yes/No)	(Qty.)	Remarks
1	DP cable	2	1.8	Yes	0	Provided by Lab
2	DVI cable	1	1.8	Yes	2	Provided by Lab
3	3 HDMI cable		2	Yes	0	Provided by Lab, HDMI 2.0 (Brand: Amber, Model: HDMI-AA120)
4	USB 2.0 cable	1	1.8	Yes	0	Provided by Lab
5	USB 2.0 cable	1	1.8	Yes	0	Provided by Lab
6	RJ45 (Cat. 5e) cable	2	10	Yes	0	Provided by Lab
7	USB Type A to C cable	4	0.5	Yes	0	Provided by Lab
8	Type C to C cable	1	0.5	Yes	0	Provided by Lab
9	Data cable	5	0.3	No	0	Supplied by applicant
10	RJ45 (Cat. 5e) cable	4	5	Yes	0	Provided by Lab
11	Audio (3.5") cable	1	2	No	0	Provided by Lab
12	GND (PE) cable	1	3	No	0	Provided by Lab
13	DC power cable	1	1.5	No	2	Accessory of EUT
14	AC power(3pin) cable	1	1.8	No	0	Provided by Lab



5 Conducted Disturbance at Auxiliary a.c. or d.c. Power Ports

5.1 Limits

Frequency (MHz)	Quasi-peak, (dBuV)
0.15 - 0.5	99
0.5 - 30	93

Notes: 1. The lower limit shall apply at the transition frequencies.

2. The limit decreases linearly with the logarithm of the frequency in the range of 0.15 to 0.50 MHz.

5.2 Test Instruments

Description	Model No. Serial No.		Calibrated Date	Calibrated Until
Manufacturer				
50 ohm terminal	0900510	E1-011285	2022/9/19	2023/9/18
LYNICS		E1-011286	2022/9/19	2023/9/18
50 Ohms Terminator LYNICS	0900510	E1-01-305	2023/2/13	2024/2/12
Attenuator STI	STI02-2200-10	NO.3	2022/10/21	2023/10/20
Coupling/Dcoupling Network	CDNE-M2	00097	2022/6/1	2023/5/31
Schwarzbeck	CDNE-M3	00091	2022/6/1	2023/5/31
Coupling/Dcoupling Network TESEQ	CDN A201A	44601	2022/12/14	2023/12/13
DC LISN	ESH3-Z6	100219	2022/8/2	2023/8/1
R&S	ESH3-20	844950/018	2022/8/2	2023/8/1
High Voltage Probe Schwarzbeck	TK9420	00982	2022/12/14	2023/12/13
Isolation Transformer Erika Fiedler	D-65396	017	2022/9/8	2023/9/7
LISN	0005/0	9204-1964	2022/6/17	2023/6/16
EMCO	3825/2	9504-2359	2022/8/2	2023/8/1
		101195	2022/8/1	2023/7/31
LISN R&S	ENV216	101196	2022/5/24	2023/5/23
Ra3		101197	2022/7/5	2023/7/4
	NNLK 8121	8121-00759	2022/8/18	2023/8/17
LISN Schwarzbeck	ININLK 0121	8121-731	2022/5/26	2023/5/25
Schwarzbeck	NNLK8129	8129229	2022/6/8	2023/6/7
RF Coaxial Cable Commate	5D-FB	Cable-CO3-01	2022/9/14	2023/9/13
Software BVADT	Cond_V7.3.7.4	N/A	N/A	N/A
Test Receiver R&S	ESR3	102413	2023/2/7	2024/2/6

Notes:

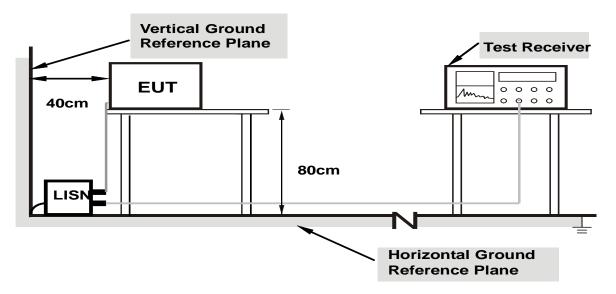
1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

- 2. The test was performed in Linkou Conduction 3.
- 3. The VCCI Site Registration No. C-10274.
- 4. Tested Date: 2023/5/5



5.3 Test Arrangement

- a. The EUT was placed 0.4 meters from the conducting wall of the shielded room with EUT being connected to the power mains through a line impedance stabilization network (LISN). Other support units were connected to the power mains through another LISN. The two LISNs provide 50 Ohm/ 50uH of coupling impedance for the measuring instrument.
- b. Both lines of the power mains connected to the EUT were checked for maximum conducted interference.
- c. The test results of conducted emissions at mains ports are recorded of six worst margins for quasi-peak (mandatory) [and average (if necessary)] values against the limits at frequencies of interest unless the margin is 20 dB or greater.
- Note: The resolution bandwidth and video bandwidth of test receiver is 9kHz for quasi-peak detection (QP) and average detection (AV) at frequency 0.15MHz-30MHz.



Note: Support units were connected to second LISN.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



5.4 Test Results

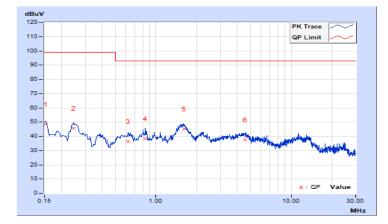
Mode A

Frequency Range	150 kHz ~ 30 MHz	Detector Function & Resolution Bandwidth	Quasi-Peak (QP), 9kHz
Input Power	230 Vac, 50 Hz	Environmental Conditions	25°C, 75% RH
Tested by	Perry Yang		

	Phase Of Power : Line (L)									
No	Frequency	Correction Factor	Reading Value (dBuV)	Emission Level (dBuV)	Limit (dBuV)	Margin (dB)				
	(MHz)	(dB)	Q.P.	Q.P.	Q.P.	Q.P.				
1	0.15408	9.65	38.95	48.60	99.00	-50.40				
2	0.24606	9.65	35.94	45.59	99.00	-53.41				
3	0.62400	9.65	26.79	36.44	93.00	-56.56				
4	0.83577	9.66	28.64	38.30	93.00	-54.70				
5	1.60406	9.68	35.48	45.16	93.00	-47.84				
6	4.58337	9.76	28.01	37.77	93.00	-55.23				

Remarks:

- 1. Q.P. is abbreviations of quasi-peak individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value



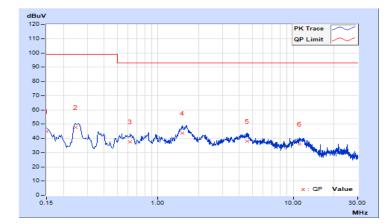


Frequency Range	150 kHz ~ 30 MHz	Detector Function & Resolution Bandwidth	Quasi-Peak (QP), 9kHz
Input Power	230 Vac, 50 Hz	Environmental Conditions	25°C, 75% RH
Tested by	Perry Yang		

	Phase Of Power : Neutral (N)									
No	Frequency	Correction Factor	Reading Value (dBuV)	Emission Level (dBuV)	Limit (dBuV)	Margin (dB)				
	(MHz)	(dB)	Q.P.	Q.P.	Q.P.	Q.P.				
1	0.15004	9.65	35.09	44.74	99.00	-54.26				
2	0.24487	9.65	37.95	47.60	99.00	-51.40				
3	0.62389	9.66	27.86	37.52	93.00	-55.48				
4	1.51999	9.69	33.89	43.58	93.00	-49.42				
5	4.58396	9.77	28.19	37.96	93.00	-55.04				
6	11.10398	9.90	26.14	36.04	93.00	-56.96				

Remarks:

- 1. Q.P. is abbreviations of quasi-peak individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value





6 Radiated Disturbance up to 1 GHz

6.1 Limits

Frequency (MHz)	dBuV/m (at 10m) / quasi-peak
30 - 230	40
230 - 1000	47

Notes: 1. The lower limit shall apply at the transition frequencies.

2. Emission level (dBuV/m) = 20 log Emission level (uV/m).

3. All emanations from a class A/B digital device or system, including any network of conductors and apparatus connected thereto, shall not exceed the level of field strengths specified above.

6.2 Test Instruments

Description Manufacturer	Model No.	Serial No.	Calibrated Date	Calibrated Until
ADT. Tower	AT100	0205	N/A	N/A
ADT. Turn Table	TT100	0205	N/A	N/A
Attenuator Mini-Circuits	UNAT-5+	PAD-ST2-01	2022/10/21	2023/10/20
Bi-log Broadband Antenna Schwarzbeck	VULB9168	9168-303	2022/10/25	2023/10/24
Coupling/Dcoupling Network	CDNE-M2	00097	2022/6/1	2023/5/31
Schwarzbeck	CDNE-M3	00091	2022/6/1	2023/5/31
Preamplifier Agilent	8447D	2944A11062	2023/2/15	2024/2/14
Pre_Amplifier EMCI	EMC9135	980711	2023/3/12	2024/3/11
Pre_Amplifier HP	8447D	2944A08313	2023/2/15	2024/2/14
RF Coaxial Cable Pacific	8D-FB	Cable-ST2-01	2022/10/21	2023/10/20
Software BVADT	Radiated_V7.6.15.9.5	N/A	N/A	N/A
TEST RECEIVER	ESCS 30	100276	2023/4/20	2024/4/19
R&S	E303 30	100292	2022/8/30	2023/8/29

Notes:

1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. The test was performed in Linkou Open Site2, The test site validated date: 2022/7/16 (NSA)

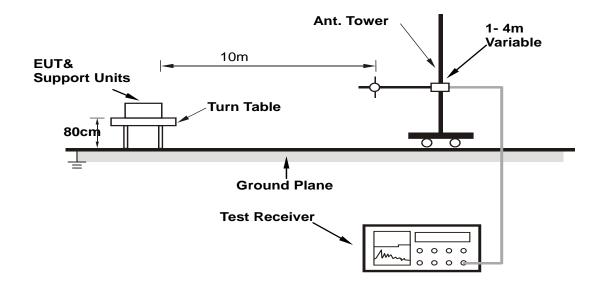
3. The VCCI Site Registration No. R-10237.

4. Tested Date: 2023/5/4



6.3 Test Arrangement

- a. The EUT was placed on the top of a rotating table 0.8 meters above the ground at an accredited test facility. The table was rotated 360 degrees to determine the position of the highest radiation.
- b. The EUT was set 10 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- c. The antenna is a broadband antenna, and its height is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- d. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meters and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- e. The test-receiver system was set to quasi-peak detect function and specified bandwidth with maximum hold mode when the test frequency is up to 1 GHz.
- Note: The resolution bandwidth and video bandwidth of test receiver/spectrum analyzer is 120kHz for quasi-peak detection (QP) at frequency up to 1GHz.



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



6.4 Test Results

Mode A

Frequency Range	30 MHz ~ 1 GHz	Detector Function & Resolution Bandwidth	Quasi-Peak (QP), 120 kHz
Tested By	Paul Chen	Environmental Conditions	26°C, 68% RH

	Antenna Polarity & Test Distance : Horizontal at 10 m								
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)	
1	74.54	33.59 QP	40.00	-6.41	4.00 H	192	45.39	-11.80	
2	125.02	31.19 QP	40.00	-8.81	4.00 H	277	41.01	-9.82	
3	148.68	30.92 QP	40.00	-9.08	4.00 H	269	38.90	-7.98	
4	200.01	30.97 QP	40.00	-9.03	4.00 H	196	41.72	-10.75	
5	222.51	36.27 QP	40.00	-3.73	4.00 H	318	46.70	-10.43	
6	250.01	37.27 QP	47.00	-9.73	3.81 H	169	45.37	-8.10	
7	349.98	39.17 QP	47.00	-7.83	3.16 H	277	44.18	-5.01	
8	462.02	43.39 QP	47.00	-3.61	2.13 H	225	45.56	-2.17	
9	499.99	38.87 QP	47.00	-8.13	1.88 H	228	40.56	-1.69	
10	547.51	46.11 QP	47.00	-0.89	1.93 H	250	46.79	-0.68	
11	616.02	44.13 QP	47.00	-2.87	1.52 H	267	42.59	1.54	
12	662.49	46.19 QP	47.00	-0.81	1.24 H	263	43.31	2.88	
13	924.01	39.25 QP	47.00	-7.75	1.00 H	192	30.78	8.47	
14	999.98	41.99 QP	47.00	-5.01	1.00 H	144	32.50	9.49	

Remarks:

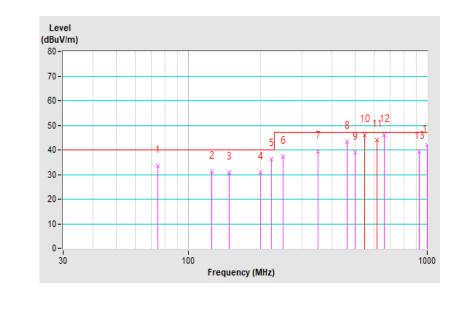
1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)

2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB)

- Pre-Amplifier Factor (dB)

3. The other emission levels were very low against the limit.

4. Margin value = Emission level - Limit value





Frequency Range	30 MHz ~ 1 GHz	Detector Function & Resolution Bandwidth	Quasi-Peak (QP), 120 kHz
Tested By	Paul Chen	Environmental	26°C, 68% RH

	Antenna Polarity & Test Distance : Vertical at 10 m							
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)
1	76.82	34.29 QP	40.00	-5.71	1.54 V	321	46.78	-12.49
2	85.49	33.65 QP	40.00	-6.35	1.89 V	248	47.86	-14.21
3	115.61	31.13 QP	40.00	-8.87	1.00 V	277	41.88	-10.75
4	124.99	36.82 QP	40.00	-3.18	1.00 V	252	46.66	-9.84
5	198.01	34.67 QP	40.00	-5.33	1.00 V	289	45.43	-10.76
6	222.44	35.27 QP	40.00	-4.73	1.00 V	180	45.70	-10.43
7	249.99	34.14 QP	47.00	-12.86	1.00 V	196	42.24	-8.10
8	308.02	38.27 QP	47.00	-8.73	1.00 V	333	44.07	-5.80
9	462.01	45.49 QP	47.00	-1.51	1.00 V	224	47.66	-2.17
10	499.99	37.29 QP	47.00	-9.71	1.00 V	256	38.98	-1.69
11	547.52	41.82 QP	47.00	-5.18	3.66 V	297	42.50	-0.68
12	616.01	44.27 QP	47.00	-2.73	3.19 V	250	42.73	1.54
13	924.01	40.18 QP	47.00	-6.82	2.36 V	172	31.71	8.47
14	999.98	39.72 QP	47.00	-7.28	2.08 V	161	30.23	9.49

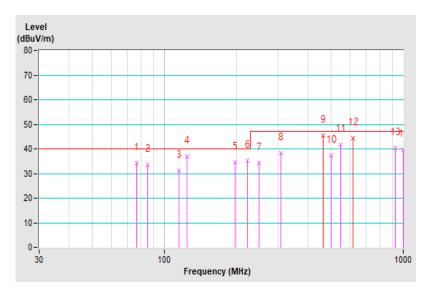
Remarks:

1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)

2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB)

– Pre-Amplifier Factor (dB)

- 3. The other emission levels were very low against the limit.
- 4. Margin value = Emission level Limit value





7 Radiated Disturbance above 1 GHz

7.1 Limits

dBuV/m	ı (at 3m)
Average	Peak
56	76
60	80
	Average 56

Notes: 1. The lower limit shall apply at the transition frequencies.

2. Emission level (dBuV/m) = 20 log Emission level (uV/m).

3. All emanations from a class A/B digital device or system, including any network of conductors and apparatus connected thereto, shall not exceed the level of field strengths specified above.

Frequency Range (For unintentional radiators)

Highest frequency generated or used in the EUT or on which the EUT operates or tunes (MHz)	Upper frequency of measurement range (MHz)
Below 108	1000
108-500	2000
500-1000	5000
Above 1000	Up to 5 times of the highest frequency or 6 GHz, whichever is less



7.2 Test Instruments

Description Manufacturer	Model No.	Serial No.	Calibrated Date	Calibrated Until
Attenuator	BW-K3-2W44+	PAD-CH7-03	2022/7/7	2023/7/6
Mini-Circuits	BW-N4W5+	PAD-CH10-02	2022/7/7	2023/7/6
Band Pass Filter MICRO-TRONICS	BRM17690	005	2022/5/26	2023/5/25
Fix tool for Boresight antenna tower BV	BAF-01	9	N/A	N/A
Horn Antenna EMCO	3115	6714	2022/11/13	2023/11/12
Horn Antenna ETS-Lindgren	3117-PA	00215857	2023/2/3	2024/2/2
Horn Antenna Schwarzbeck	BBHA 9170	212	2022/10/20	2023/10/19
Notch Filter MICRO-TRONICS	BRC50703-01	010	2022/5/26	2023/5/25
Pre-amplifier HP	8449B	3008A01292	2023/2/16	2024/2/15
Pre_Amplifier	EMC0126545	980076	2023/2/16	2024/2/15
EMCI	EMC184045B	980235	2023/2/16	2024/2/15
RF Coaxial Cable EM	EM102-KMKM-3.5	EM102-KMKM-3.5-02	2022/9/27	2023/9/26
RF Coaxial Cable WOKEN	WC01	Cable-CH10-03	2022/9/27	2023/9/26
Software BVADT	Radiated_V8.7.08	N/A	N/A	N/A
Spectrum	N9020B	MY60110438	2022/12/6	2023/12/5
Keysight	INSUZUD	MY60112260	2022/5/21	2023/5/20
Test Receiver Agilent	N9038A	MY51210137	2022/6/9	2023/6/8
Turn Table & Tower Max Full	MF7802	MF780208216	N/A	N/A

Notes:

1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. The test was performed in Linkou 966 Chamber 3 (CH 10).

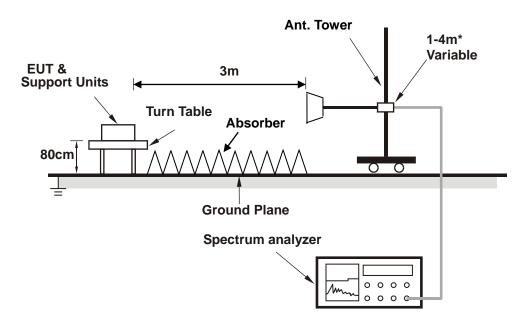
3. The VCCI Site Registration No. G-10427.

4. Tested Date: 2023/5/6



7.3 Test Arrangement

- a. The EUT was placed on the top of a rotating table 0.8 meters above the ground at an accredited chamber room. The table was rotated 360 degrees to determine the position of the highest radiation.
- b. The EUT was set 3 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- c. The height of antenna can be varied from one meter to four meters, the height of adjustment depends on the EUT height and the antenna 3dB beamwidth both, to detect the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- d. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- e. The spectrum analyzer system was set to peak and average detect function and specified bandwidth with maximum hold mode when the test frequency is above 1 GHz.
- Note: The resolution bandwidth of test receiver/spectrum analyzer is 1MHz and video bandwidth is 3MHz for Peak detection (PK) at frequency above 1GHz. The resolution bandwidth of test receiver/spectrum analyzer is 1 MHz for Average detection (AV) at frequency above 1GHz.



* :depends on the EUT height and the antenna 3dB beamwidth both.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



7.4 Test Results

Mode A

Frequency Range	1 GHz ~ 6 GHz	Detector Function & Resolution Bandwidth	Peak (PK) / Average (AV), 1MHz
Tested By	Bob Lin	Environmental Conditions	20°C, 70% RH

	Antenna Polarity & Test Distance : Horizontal at 3 m							
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)
1	1539.97	54.79 PK	76.00	-21.21	1.47 H	286	57.93	-3.14
2	1539.97	43.91 AV	56.00	-12.09	1.47 H	286	47.05	-3.14
3	1847.99	50.41 PK	76.00	-25.59	1.30 H	94	52.26	-1.85
4	1847.99	37.96 AV	56.00	-18.04	1.30 H	94	39.81	-1.85
5	2001.96	52.86 PK	76.00	-23.14	1.00 H	111	54.23	-1.37
6	2001.96	44.74 AV	56.00	-11.26	1.00 H	111	46.11	-1.37
7	2309.99	56.48 PK	76.00	-19.52	2.31 H	66	56.96	-0.48
8	2309.99	41.84 AV	56.00	-14.16	2.31 H	66	42.32	-0.48
9	2463.99	56.45 PK	76.00	-19.55	2.30 H	81	56.50	-0.05
10	2463.99	41.81 AV	56.00	-14.19	2.30 H	81	41.86	-0.05
11	3695.92	58.91 PK	80.00	-21.09	2.44 H	136	53.95	4.96
12	3695.92	43.38 AV	60.00	-16.62	2.44 H	136	38.42	4.96
13	3849.99	62.54 PK	80.00	-17.46	1.84 H	134	57.10	5.44
14	3849.99	47.46 AV	60.00	-12.54	1.84 H	134	42.02	5.44

Remarks:

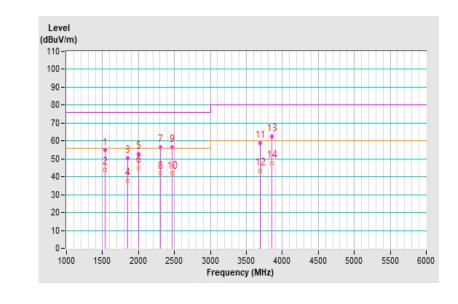
1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)

2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB)

- Pre-Amplifier Factor (dB)

3. The other emission levels were very low against the limit.

4. Margin value = Emission level - Limit value





Frequency Range	1 GHz ~ 6 GHz	Detector Function & Resolution Bandwidth	Peak (PK) / Average (AV), 1MHz
Tested By	Bob Lin	Environmental Conditions	20°C, 70% RH

	Antenna Polarity & Test Distance : Vertical at 3 m							
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)
1	1539.98	60.68 PK	76.00	-15.32	2.01 V	130	63.82	-3.14
2	1539.98	50.37 AV	56.00	-5.63	2.01 V	130	53.51	-3.14
3	1928.75	54.68 PK	76.00	-21.32	1.00 V	220	56.49	-1.81
4	1928.75	37.01 AV	56.00	-18.99	1.00 V	220	38.82	-1.81
5	2309.95	56.83 PK	76.00	-19.17	1.06 V	205	57.31	-0.48
6	2309.95	42.62 AV	56.00	-13.38	1.06 V	205	43.10	-0.48
7	3079.97	57.93 PK	80.00	-22.07	2.35 V	2	55.47	2.46
8	3079.97	45.55 AV	60.00	-14.45	2.35 V	2	43.09	2.46
9	3695.97	55.92 PK	80.00	-24.08	2.46 V	51	50.96	4.96
10	3695.97	42.10 AV	60.00	-17.90	2.46 V	51	37.14	4.96
11	3849.95	62.68 PK	80.00	-17.32	2.16 V	181	57.24	5.44
12	3849.95	47.10 AV	60.00	-12.90	2.16 V	181	41.66	5.44

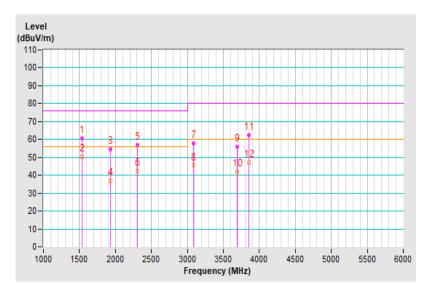
Remarks:

1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)

2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB)

- Pre-Amplifier Factor (dB)

- 3. The other emission levels were very low against the limit.
- 4. Margin value = Emission level Limit value





8 Harmonics Current Measurement

8.1 Limits

Limits fo	or Class A equipment		Limits for Class D equi	pment
Harmonic Order	Max. permissible harmonics current	Harmonic Order	Max. permissible harmonics current per	Max. permissible harmonics current
n	A	n	watt mA/W	A
C	Odd harmonics		Odd Harmonics on	У
3	2.30	3	3.4	2.30
5	1.14	5	1.9	1.14
7	0.77	7	1.0	0.77
9	0.40	9	0.5	0.40
11	0.33	11	0.35	0.33
13	0.21	13	0.30	0.21
15≦n≦39	0.15 x 15/n	15≦n≦39	3.85/n	0.15 x 15/n
E	ven harmonics			
2	1.08			
4	0.43			
6	0.30			
8≦n≦40	0.23 x 8/n			

Notes: 1. Class A and Class D are classified according to section 5 of EN 61000-3-2.

 According to section 7 of EN 61000-3-2, the above limits for all equipment except for lighting equipment having an active input power > 75 W and no limits apply for equipment with an active input power up to and including 75 W.

8.2 Classification of Equipment

		010	
Class A	Class B	Class C	Class D
Balanced three-phase equipment;	Portable tools;	Lighting	Equipment having a specified
Household appliances excluding	Arc welding	equipment.	power less than or equal to 600
equipment as Class D;	equipment which is		W of the following types:
Tools excluding portable tools;	not professional		Personal computers and
Dimmers for incandescent lamps;	equipment.		personal computer monitors;
Audio equipment;			Television receivers;
Equipment not specified in one of the			Refrigerators and freezers
three other classes.			having one or more
			variable-speed drives to control
			compressor motor(s).

8.3 Test Instruments

Description Manufacturer	Model No.	Serial No.	Calibrated Date	Calibrated Until
Harmonics and Flicker Analyzer TESEQ	PROFLINE 2105	1632A00983&1639A01863	2022/6/8	2023/6/7
Software	CTS 4	N/A	N/A	N/A

Notes:

1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

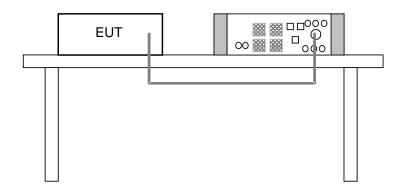
2. The test was performed in Linkou EMS Room No.1.

3. Tested Date: 2023/5/9



8.4 Test Arrangement

- a. The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the maximum harmonic components under normal operating conditions for each successive harmonic component in turn.
- b. The correspondent test program of test instrument to measure the current harmonics emanated from EUT is chosen. The measure time shall be not less than the time necessary for the EUT to be exercised.



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



8.5 Test Results

Mode A

Test Duration	5 min	Fundamental Voltage / Ampere	230.18 Vrms / 0.497 Arms
Power Consumption	101.1 W	Power Frequency	50 Hz
Power Factor	0.905	Environmental Conditions	24°C, 72% RH
Tested By	Joey Liu		

Harm#	Harms (avg) (A)	100% Limit (A)	Harms (max) (A)	150% Limit (A)
1	0.454	-	1.107	-
2	0.004	1.080	0.005	1.620
3	0.150	2.300	0.161	3.450
4	0.002	0.430	0.004	0.645
5	0.046	1.140	0.049	1.710
6	0.002	0.300	0.003	0.450
7	0.020	0.770	0.023	1.155
8	0.002	0.230	0.002	0.345
9	0.009	0.400	0.010	0.600
10	0.001	0.184	0.002	0.276
11	0.010	0.330	0.011	0.495
12	0.001	0.153	0.002	0.230
13	0.009	0.210	0.010	0.315
14	0.001	0.131	0.002	0.197
15	0.006	0.150	0.007	0.225
16	0.001	0.115	0.002	0.173
17	0.005	0.132	0.007	0.198
18	0.001	0.102	0.002	0.153
19	0.008	0.118	0.009	0.178
20	0.002	0.092	0.002	0.138
21	0.004	0.107	0.008	0.161
22	0.002	0.084	0.002	0.125
23	0.005	0.098	0.006	0.147
24	0.001	0.077	0.002	0.115
25	0.005	0.090	0.005	0.135
26	0.001	0.071	0.002	0.107
27	0.004	0.083	0.006	0.125
28	0.001	0.066	0.002	0.099
29	0.004	0.078	0.006	0.116
30	0.001	0.061	0.002	0.092
31	0.007	0.073	0.010	0.109
32	0.001	0.058	0.002	0.086
33	0.005	0.068	0.006	0.102
34	0.001	0.054	0.002	0.081
35	0.004	0.064	0.005	0.096
36	0.001	0.051	0.002	0.077
37	0.004	0.061	0.006	0.091
38	0.001	0.048	0.002	0.073
39	0.006	0.058	0.008	0.087
40	0.001	0.046	0.001	0.069

Note: Dynamic limits were applied for this test. The highest harmonics values in the above table may not occur at the same window as the maximum harmonics/limit ratio.



9 Voltage Fluctuations and Flicker Measurement

9.1 Limits

Test item	Limit	Note
Pst	1.0	Pst: short-term flicker severity.
Plt	0.65	Plt: long-term flicker severity.
T _{max} (ms)	500	$T_{max:}$ maximum time duration during the observation period that the voltage deviation d(t) exceeds the limit for d _c .
d _{max} (%)	4	d _{max:} maximum absolute voltage change during an observation period.
d _c (%)	3.3	dc maximum steady state voltage change during an observation period.

9.2 Test Instruments

Description Manufacturer	Model No.	Serial No.	Calibrated Date	Calibrated Until
Harmonics and Flicker Analyzer TESEQ	PROFLINE 2105	1632A00983&1639A01863	2022/6/8	2023/6/7
Software	CTS 4	N/A	N/A	N/A

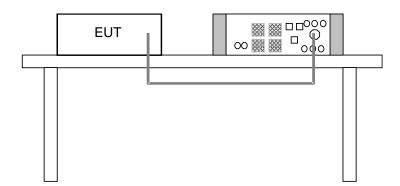
Notes:

1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

- 2. The test was performed in Linkou EMS Room No.1.
- 3. Tested Date: 2023/5/9

9.3 Test Arrangement

- a. The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the most unfavorable sequence of voltage changes under normal operating conditions.
- b. During the flick measurement, the measure time shall include that part of whole operation cycle in which the EUT produce the most unfavorable sequence of voltage changes. The observation period for short-term flicker indicator is 10 minutes and the observation period for long-term flicker indicator is 2 hours.



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



9.4 Test Results

Mode A

Observation (Tp)	rvation (Tp) 10 min			
Input Power	230 Vac, 50 Hz	Environmental Conditions	24°C, 72% RH	
Tested By	Joey Liu			

Test Parameter	Measurement Value	Limit	Remarks
Pst	0.263	1.00	Pass
Plt	0.115	0.65	Pass
T _{max} (ms)	0.000	500	Pass
d _{max} (%)	0.000	4.00	Pass
d _c (%)	0.000	3.30	Pass

Notes:

a. P_{st} means short-term flicker indicator.

b. P_{lt} means long-term flicker indicator.

c. T_{max} means accumulated time value of d(t) with a deviation exceeding 3.3 %.

d. d_{max} means maximum relative voltage change.

e. d_c means maximum relative steady-state voltage change.

10 Electrostatic Discharge Immunity Test (ESD)

10.1 Test Specification

Basic Standard: Discharge Impedance:	EN 61000-4-2 330 ohm / 150 pF
Discharge Voltage:	Air Discharge: ±2, ±4, ±8kV (Direct) Contact Discharge: ±2, ±4, ±6kV (Indirect & Direct)
Number of Discharge:	Minimum 20 times at each test point
Discharge Mode:	Single Discharge
Discharge Period:	1-second minimum

10.2 Test Instruments

Description Manufacturer	Model No.	Serial No.	Calibrated Date	Calibrated Until
Electronic Discharge Simulator Noiseken	ESS-2000	ESS0382041	2022/10/7	2023/10/6
Electrostatic Analog Tester TESEQ	NSG 438	1875	2022/11/11	2023/11/10
ESD Generator EM Test	Dito//DM-150/330//DM-150/330-rfci	P1315117252/P1317117852	2022/7/7	2023/7/6
ESD Simulator EM TEST	Dito	V0707102251	2023/3/24	2024/3/23
ESD Simulator KeyTek	MZ15/EC	0504259	2022/11/8	2023/11/7
ESD Simulator TESEQ	NSG 438	1364	2022/12/2	2023/12/1

Notes:

1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. The test was performed in Linkou ESD Room No.01.



- a. Electrostatic discharges were applied only to those points and surfaces of the EUT that are accessible to users during normal operation.
- b. The test was performed with at least ten single discharges on the pre-selected points in the most sensitive polarity.
- c. The time interval between two successive single discharges was at least 1 second.
- d. The ESD generator was held perpendicularly to the surface to which the discharge was applied and the return cable was at least 0.2 meters from the EUT.
- e. Contact discharges were applied to the non-insulating coating, with the pointed tip of the generator penetrating the coating and contacting the conducting substrate.
- f. Air discharges were applied with the round discharge tip of the discharge electrode approaching the EUT as fast as possible (without causing mechanical damage) to touch the EUT. After each discharge, the ESD generator was removed from the EUT and re-triggered for a new single discharge. The test was repeated until all discharges were complete.
- g. At least ten single discharges (in the most sensitive polarity) were applied to the Horizontal Coupling Plane at points on each side of the EUT. The ESD generator was positioned at a distance of 0.1 meters from the EUT with the discharge electrode touching the HCP.
- h. At least ten single discharges (in the most sensitive polarity) were applied to the center of one vertical edge of the Vertical Coupling Plane in sufficiently different positions that the four faces of the EUT were completely illuminated. The VCP (dimensions 0.5m x 0.5m) was placed vertically to and 0.1 meters from the EUT.

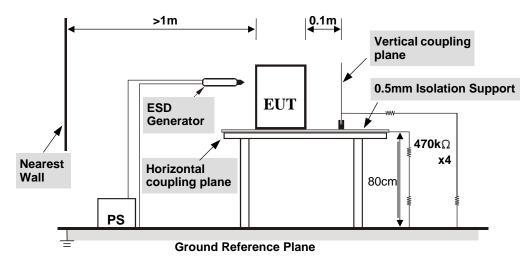


TABLE-TOP EQUIPMENT

The configuration consisted of a wooden table 0.8 meters high standing on the Ground Reference Plane. The **GRP** consisted of a sheet of aluminum at least 0.25mm thick, and 2.5 meters square connected to the protective grounding system. A Horizontal Coupling Plane (1.6m x 0.8m) was placed on the table and attached to the **GRP** by means of a cable with 940k Ω total impedance. The equipment under test, was installed in a representative system as described in section 7 of

EN 61000-4-2, and its cables were placed on the **HCP** and isolated by an insulating support of 0.5mm thickness. A distance of 1-meter minimum was provided between the EUT and the walls of the laboratory and any other metallic structure.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



10.4 Test Results

Mode A

Input Power	230Vac, 50 Hz	Tested by	Chiming Li
Environmental Conditions	24 °C, 43 % RH, 1007 mbar		

	Test Results of Direct Application							
Discharge Level (kV)								
2, 4, 6	+/- 1-4,8-12,18,19,20 Note 1 A							
2, 4	+/-	5,6,7,13-17,21		Note 1	А			
8	+/-	5,6,13-17,21		Note 1	A			
8	+/-	7		Note 2	В			

Description of test points of direct application: Please refer to following page for representative mark only.

Test Results of Indirect Application							
Discharge Polarity Test Point Horizontal Vertical Coupling Performance							
Level (kV)	Level (kV) (+/-) Test Point Coupling Plane Plane Criterion						
2, 4, 6 +/- Four Side Note 1 Note 1 A							
Description of	Description of test points of indirect application:						

Description of test points of indirect application:

1. Front side

2. Rear side

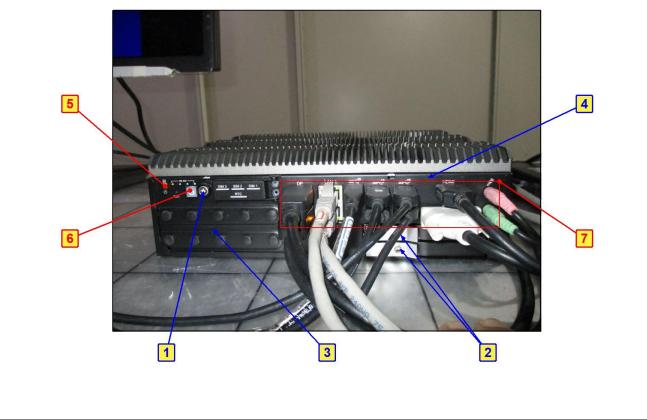
3. Right side

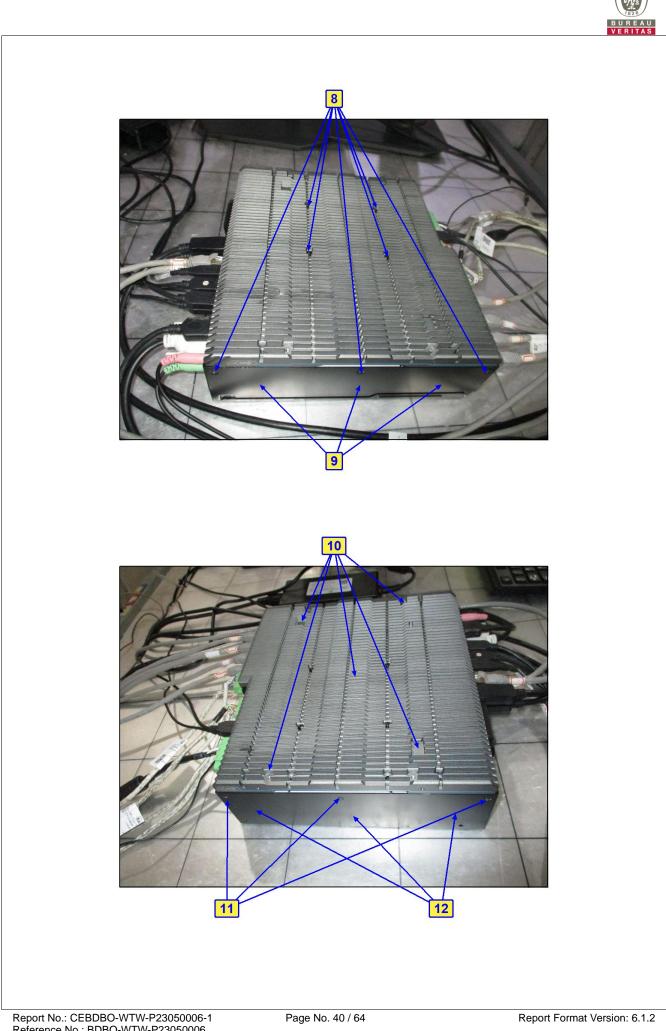
4. Left side

Note: 1. The EUT is operated normal during the test.

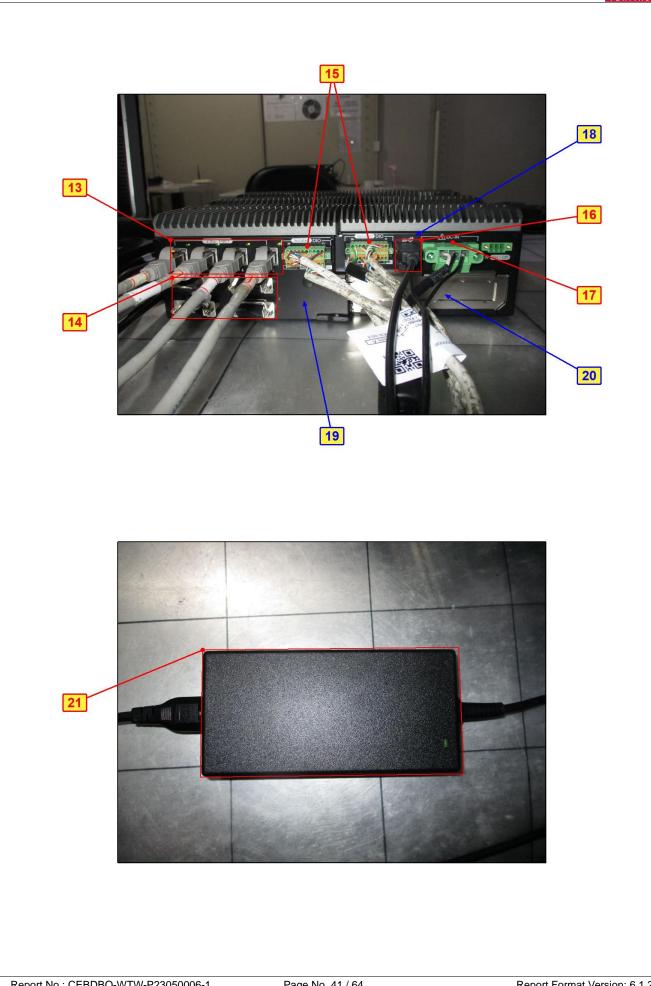
2. The output monitor's screen have flicker during the test, but self-recoverable after the test.

Description of Test Points









11 Radio-frequency Electromagnetic Field Immunity Test (RS)

11.1 Test Specification

Basic Standard:	EN 61000-4-3		
	80-800 MHz, 20V/m ¹		
Fraguency Dongo Field	800-1000 MHz, 20V/m		
Frequency Range, Field Strength:	1400-2000 MHz, 10V/m		
Chongan	2000-2700 MHz, 5V/m		
	5100-6000 MHz, 3V/m		
Modulation:	1kHz Sine Wave, 80%, AM Modulation		
Frequency Step:	1 % of preceding frequency value		
Polarity of Antenna:	Horizontal and Vertical		
Antenna Height:	1.5m		
Dwell Time:	3 seconds		

Note 1: This limit applies to equipment mounted in the passenger compartments, drivers cab or external to the rolling stock (roof, underframe). For equipment mounted in all other areas a severity level of 10 V/m may be used.

11.2 Test Instruments

Description Manufacturer	Model No.	Serial No.	Calibrated Date	Calibrated Until
* Broadband Field Meter Narda	NBM-550	B-0872	2022/3/18	2024/3/17
Amplifier BONN	BSA 0125-800	1912556	N/A	N/A
Amplifier TESTQ	CBA 1G-275	T44344	N/A	N/A
Audio analyzer R&S	UPV	104565	2022/5/10	2023/5/9
Band pass filter B&K	WH3278	N/A	2022/6/5	2023/6/4
BiconiLog Antenna EMCO	3141	1001	N/A	N/A
CHANCE MOST Full Anechoic Chamber (9x5x3m)	Chance Most	RS-002	2023/2/3	2024/2/2
Controller AR	SC1000M3	305910	N/A	N/A
Ear Simulator Telephonometry B&K	4185	2553594	N/A	N/A
High Gain Horn Antenna AR	AT4010	0329800	N/A	N/A
LOG ANTENNA Schwarzbeck	Schwarzbeck Stlp 9149	9149-260	N/A	N/A
Log-Periodic Antenna AR	AT6080	0329465	N/A	N/A



Power Amplifier	35S4G8AM4	0326094	N/A	N/A
AR	100S1G4M3	0329249	N/A	N/A
Power Meter BOONTON	4232A	94901	2022/6/6	2023/6/5
Power Sensor	51011-EMC	32807	2022/6/6	2023/6/5
BOONTON	51011-EIMC	32832	2022/6/6	2023/6/5
Pressure-field Microphone B&K	4192	3190854	2022/12/12	2023/12/11
Signal Generator Agilent	E8257D	MY48050465	2022/6/29	2023/6/28
Software BVADT	RS_V7.6	N/A	N/A	N/A
Software	ABMS_ V7.4.3	N/A	N/A	N/A
Two channel microphone conditioning amplifier B&K	2690 A OS2	2645274	2022/6/5	2023/6/4
Wireless Connection Tester R&S	CMW270	101075	2023/4/28	2024/4/27

Notes:

1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. * The calibration interval of the above test instruments is 24 months and the calibrations are traceable to NML/ROC and NIST/USA

3. The test was performed in Linkou RS Room No.02.



The test procedure was in accordance with EN 61000-4-3.

- a. The testing was performed in a fully anechoic chamber.
- b. The frequency ranges and field strength levels are 80-800 MHz, 20V/m, 800-1000 MHz, 20V/m, 1400-2000 MHz, 10V/m, 2000-2700 MHz, 5V/m and 5100-6000 MHz, 3V/m with the signal 80% amplitude modulated with a 1kHz sine wave.
- c. The test was performed with the EUT exposed to both vertically and horizontally polarized fields on each of the four sides.

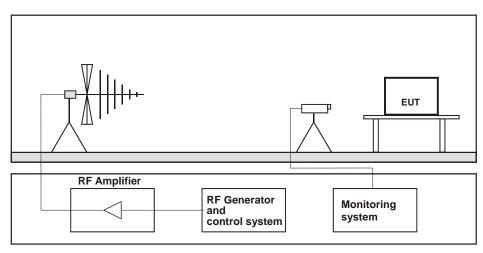


Table-top Equipment

The EUT installed in a representative system as described in section 7 of EN 61000-4-3 was placed on a non-conductive table 0.8 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

11.4 Test Results

Mode A			
Input Power	230Vac, 50 Hz	Tested by	Joey Liu
Environmental Conditions	22 °C, 71 % RH		

Frequency (MHz)	Polarity	Azimuth(°)		ed Field Strength	Observation	Performance Criterion
			(V/m)	Modulation		Cillenon
80 - 800	V&H	0, 90, 180, 270	20	80% AM (1kHz)	Note	A
800 - 1000	V&H	0, 90, 180, 270	20	80% AM (1kHz)	Note	А
1400 - 2000	V&H	0, 90, 180, 270	10	80% AM (1kHz)	Note	А
2000 - 2700	V&H	0, 90, 180, 270	5	80% AM (1kHz)	Note	А
5100 - 6000	V&H	0, 90, 180, 270	3	80% AM (1kHz)	Note	A

Note: The EUT is operated normal during the test.



12 Electrical Fast Transient/Burst Immunity Test (EFT)

12.1 Test Specification

Basic Standard:	EN 61000-4-4
Test Voltage:	Signal & communication, process measurement & control ports: ±2kV, Capacitive clamp
	Battery referenced ports (except at the output of energy sources), Auxiliary a.c. power input ports (rated voltage \leq 400 Vrms): \pm 2kV
Impulse Repetition Frequency:	5kHz
Impulse Wave Shape:	5/50 (T _r /T _h) ns
Burst Duration:	15 ms
Burst Period:	300 ms
Test Duration:	1 min.

12.2 Test Instruments

Description Manufacturer	Model No.	Serial No.	Calibrated Date	Calibrated Until
Burst generator Haefely	PEFT 4010	154954	2023/3/24	2024/3/23

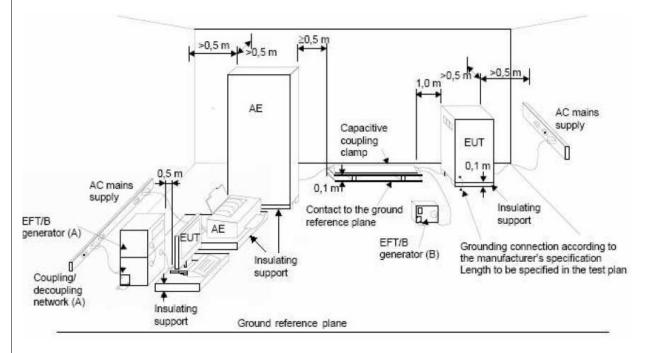
Notes:

1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. The test was performed in Linkou EFT Room.



- a. Both positive and negative polarity discharges were applied.
- b. The distance between any coupling devices and the EUT should be 0.5 m for table-top equipment testing, and 1.0 m for floor standing equipment.
- c. The duration time of each test sequential was 1 minute.
- d. The transient/burst waveform was in accordance with EN 61000-4-4, 5/50 ns.



NOTE:

(A) location for supply line coupling

(B) location for signal lines coupling

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



12.4 Test Results

Mode A

Input Power	230Vac, 50 Hz	Tested by	Chiming Li
Environmental Conditions	25 °C, 71 % RH		

Battery referenced ports (except at the output of energy sources), Auxiliary a.c. power input ports (rated voltage \leq 400 Vrms)

Voltage (kV)	Test Point	Polarity (+/-)	Observation	Performance Criterion			
2	L	+/-	Note	А			
2	Ν	+/-	Note	А			
2	PE	+/-	Note	А			
2	L-N-PE	+/-	Note	А			

Signal & communication, process measurement & control ports

Voltage (kV)	Test Point	Polarity (+/-)	Observation	Performance Criterion
2	LAN 1	+/-	Note	А
2	LAN 2	+/-	Note	А
2	LAN 6 (PoE)	+/-	Note	A

Note: The EUT is operated normal during the test.



13 Surge Immunity Test

13.1 Test Specification

Basic Standard: Wave-Shape:	EN 61000-4-5 Battery referenced ports (except at the output of energy sources), Auxiliary a.c. power input ports (rated voltage ≤ 400 Vrms): 1.2/50 µs Open Circuit Voltage 8/20 µs Short Circuit Current
Test Voltage:	Line to line: ±0.5kV, ±1kV, Line to ground: ±0.5kV, ±1kV, ±2kV output impedance of 42 Ω (40 Ω and 2 Ω generator) and a coupling capacitance of 0,5 μF
AC Phase Angle (degree): Pulse Repetition Rate:	0°, 90°, 180°, 270° 1 time / 20 sec.
Number of Tests:	5 positive and 5 negative at selected points

13.2 Test Instruments

Description Manufacturer	Model No.	Serial No.	Calibrated Date	Calibrated Until
CDN for Unshielded Unsymmetrical Signal & Data Lines TESEQ	CDN117	40144	2022/8/23	2023/8/22
Coupling Decoupling Network EMC-Partner	CDN-UTP8	045	2022/8/2	2023/8/1
Coupling Decoupling Network TESEQ	CDN HSS-2	41009	2023/4/18	2024/4/17
Surge Coupling Decoupling Network TESEQ	CDN 118-T8	40386	2022/8/23	2023/8/22
Surge&EFT Generators TESEQ	NSG 3060	1572	2023/4/18	2024/4/17

Notes:

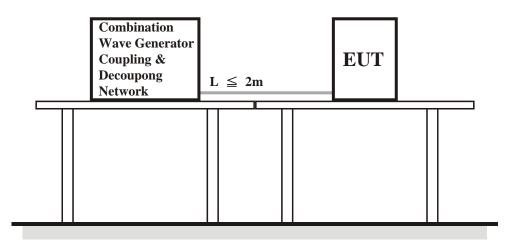
1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. The test was performed in Linkou EMS Room No.02.



The surge is to be applied to the EUT power supply terminals via the capacitive coupling network. Decoupling networks are required in order to avoid possible adverse effects on equipment not under test that may be powered by the same lines, and to provide sufficient decoupling impedance to the surge wave. The power cord between the EUT and the coupling/decoupling networks shall be 2 meters in length (or shorter).

For double-insulated products without PE or external earth connections, the test shall be done in a similar way as for grounded products but without adding any additional external grounded connections. If there are no other possible connections to earth, line-to-ground tests may be omitted.



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

13.4 Test Results

Mode A

Input Power	230Vac, 50 Hz	Tested by	Joey Liu
Environmental Conditions	21 °C, 69 % RH		

Battery referenced ports (except at the output of energy sources),

Auxiliary a.c. power input ports (rated voltage ≤ 400 Vrms)

Voltage (kV)	Test Point	Azimuth(°)	Polarity (+/-)	Observation	Performance Criteria
0.5, 1(42 Ω+0.5µF)	L-N	0,90,180,270	+/-	Note	А
0.5, 1, 2(42 Ω+0.5µF)	L-PE	0,90,180,270	+/-	Note	А
0.5, 1, 2(42 Ω+0.5µF)	N-PE	0,90,180,270	+/-	Note	А

Note: The EUT is operated normal during the test.



14 Immunity to Conducted Disturbances Induced by RF Fields (CS)

14.1 Test Specification

Basic Standard:	EN 61000-4-6
Frequency Range:	0.15 MHz - 80 MHz
Voltage Level:	Battery referenced ports (except at the output of energy sources), Auxiliary a.c. power input ports (rated voltage ≤ 400 Vrms), Signal & communication, process measurement & control ports: 10 V
Modulation:	1kHz Sine Wave, 80%, AM Modulation
Frequency Step:	1 % of preceding frequency value
Dwell Time	3 seconds

14.2 Test Instruments

Description Manufacturer	Model No.	Serial No.	Calibrated Date	Calibrated Until
CDN FCC	FCC-801-M5-50A	100018	2023/1/17	2024/1/16
CDN	CDN S200	53490	2023/2/23	2024/2/22
TESEQ	CDN S400	52115	2023/2/23	2024/2/22
CDN Calibration Kit TESEQ	CDN T8S	29459	2023/2/21	2024/2/20
CDN M2-16Amp FCC	FCC-801-M2-16A	01047	2023/2/22	2024/2/21
	CDN M432S	56519	2023/2/22	2024/2/21
		56435	2023/2/20	2024/2/19
	CDN S751A	56436	2023/2/21	2024/2/20
	CDN ST08A	56525	2023/2/20	2024/2/19
	CDN ST08A	56527	2023/2/20	2024/2/19
Coupling Decoupling Network TESEQ	CDN T2A-10	54942	2023/2/21	2024/2/20
	CDN T8-10	40376	2023/2/21	2024/2/20
		56641	2023/2/21	2024/2/20
	CDN T8-230	56642	2023/2/21	2024/2/20
	CDN T800	34428	2023/2/21	2024/2/20
	CDN T400A	49918	2023/2/22	2024/2/21
Coupling/Dcoupling Network EM TEST	CDN M1/32A	306508	2023/2/22	2024/2/21
	CDN M232	37702	2023/2/22	2024/2/21
Coupling/Dcoupling Network		41256	2023/2/22	2024/2/21
TESEQ	CDN M332	41258	2023/2/22	2024/2/21
CS Power Amplifier ETS-Lindgren	8100-010	00163535	N/A	N/A
Current Clamp FCC	F-120-9A	361	2022/8/17	2023/8/16
Ear Simulator Telephonometry B&K	4185	2553594	N/A	N/A
FCC EM Injection Clamp FCC	F-203I-23mm	455	N/A	N/A



	-			
Description Manufacturer	Model No.	Serial No.	Calibrated Date	Calibrated Until
Mouth Simulator B&K	4227	2630632	N/A	N/A
POWER AMPLIFIER B&K	2716C	2610979	N/A	N/A
Power Meter R & S	NRVD	837794/040	2022/10/18	2023/10/17
Power Sensor R & S	NRV-Z5	837878/039	2022/10/18	2023/10/17
Pressure-field Microphone B&K	4192	2735407	N/A	N/A
SIGNAL GENERATOR R&S	SML03	101364	2022/8/16	2023/8/15
Software BVADT	ABMS_ V7.4.3	N/A	N/A	N/A
Software BVADT	BVADT_CS_V7.6.6	N/A	N/A	N/A
Two channel microphone conditioning amplifier B&K	2690 OS2	3001996	2022/11/15	2023/11/14
Wireless Connection Tester R&S	CMW270	101075	N/A	N/A

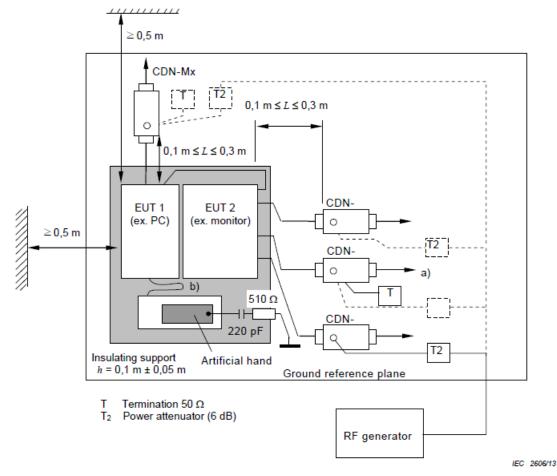
Notes:

1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. The test was performed in Linkou CS Room No.1.



- a. The EUT shall be tested within its intended operating and climatic conditions.
- b. An artificial hand was placed on the hand-held accessory and connected to the ground reference plane.
- c. One of the CDNs not used for injection was terminated with 50 ohm, providing only one return path. All other CDNs were coupled as decoupling networks.
- d. The frequency range is swept from 150 kHz to 80 MHz, using the signal level established during the setting process and with a disturbance signal of 80 % amplitude. The signal is modulated with a 1 kHz sine wave, pausing to adjust the RF signal level or the switch coupling devices as necessary. Where the frequency is swept incrementally, the step size shall not exceed 1 % of the preceding frequency value.
- e. Attempts should be made to fully exercise the EUT during testing, and to fully interrogate all exercise modes selected for susceptibility.



- Note: 1.The EUT clearance from any metallic obstacles shall be at least 0,5 m.
 - 2. Interconnecting cables (≤ 1 m) belonging to the EUT shall remain on the insulating support.
 - 3. The equipment to be tested is placed on an insulating support of 0.1 meters height above a ground reference plane. All relevant cables shall be provided with the appropriate coupling and decoupling devices at a distance between 0.1 meters and 0.3 meters from the projected geometry of the EUT on the ground reference plane.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



14.4 Test Results

Mode A

n

Input Power	230Vac, 50 Hz	Tested by	Joey Liu
Environmental Conditions	21 °C, 71 % RH		

Input AC pow	Input AC power port						
Frequency (MHz)	Level (V rms)	Modulation	Tested Line	Injection Method	Return Path	Observation	Performance Criteria
0.15 – 80	10	80% AM (1kHz)	AC	CDN-M3	CDN-M1	Note	A

Wired network and signal/ control port							
Frequency (MHz)	Level (V rms)	Modulation	Tested Line	Injection Method	Return Path	Observation	Performance Criteria
0.15 – 80	3	80% AM (1kHz)	LAN 1	CDN-ST08A	CDN-M1	Note	А
0.15 – 80	3	80% AM (1kHz)	LAN 2	CDN-ST08A	CDN-M1	Note	А
0.15 – 80	3	80% AM (1kHz)	LAN 6 (PoE)	CDN-ST08A	CDN-M1	Note	А

Note: The EUT is operated normal during the test.



15 Pictures of Test Arrangements

15.1 Conducted Disturbance at Auxiliary a.c. or d.c. power ports





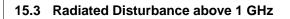
Report No.: CEBDBO-WTW-P23050006-1 Reference No.: BDBO-WTW-P23050006



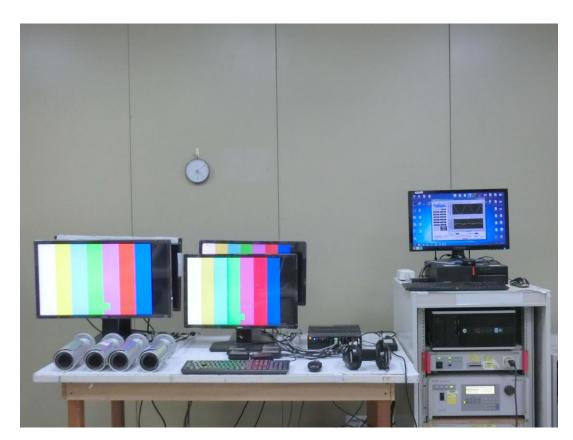
15.2 Radiated Disturbance up to 1 GHz





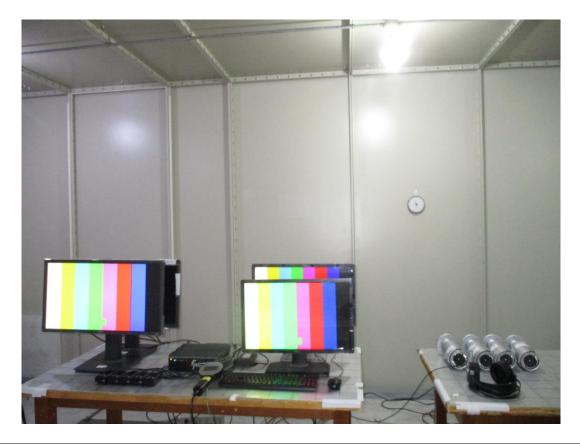






15.4 Harmonics Current, Voltage Fluctuations and Flicker Measurement

15.5 Electrostatic Discharge Immunity Test (ESD)







15.6 Radio-frequency Electromagnetic Field Immunity Test (RS)



15.7 Fast Transients (EFT)



LAN 1





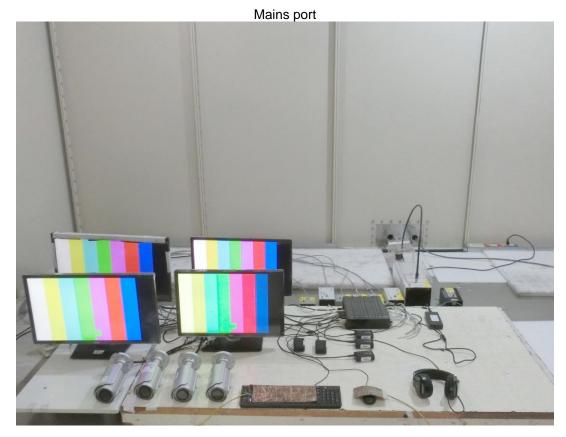


15.8 Surge





15.9 Radio-frequency common mode (CS)



LAN 1





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Appendix – Information of the Testing Laboratories

We, Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch, were founded in 1988 to provide our best service in EMC, Radio, Telecom and Safety consultation. Our laboratories are accredited and approved according to ISO/IEC 17025.

If you have any comments, please feel free to contact us at the following:

Lin Kou EMC/RF Lab

Tel: 886-2-26052180 Fax: 886-2-26051924 Hsin Chu EMC/RF/Telecom Lab Tel: 886-3-6668565 Fax: 886-3-6668323

Hwa Ya EMC/RF/Safety Lab Tel: 886-3-3183232 Fax: 886-3-3270892

Email: <u>service.adt@bureauveritas.com</u> Web Site: <u>http://ee.bureauveritas.com.tw</u>

The address and road map of all our labs can be found in our web site also.

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